

Accelerator Systems RAM Analysis

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Topics



- RAM Calculation of the SNS
 - Methodology
 - Assumptions
 - Results
- Experience at other modern accelerators (JLab, APS)
- SNS reliability goals and approach to tracking reliability data
- Projections for increased reliability

Accelerator Availability



- Neutron scientists desire a 90% steady state availability
 - Travel, many are small groups with small travel budgets
 - Targets, time sensitive materials
- A top-down apportionment sets reliability goals for subsystems
- A bottom-up analysis

RAMI



- Reliability
 - System reliability, steady state or $R(t)$ – Time dependent examples include the “bathtub curve”
- Availability
 - Availability of systems until the next maintenance period
- Maintainability
 - Ability to diagnose and repair faults
 - Ability and knowledge to schedule and perform preventative maintenance before systems fail for systems that show no pre-failure behavior
- Inspectability
 - Ability to PREDICT failure by periodic inspection and do PM to prevent failure

Reliability/Availability Calculation



- Calculated using Markov chains
 - Code obtained from APT,
- Steady state code (after infant mortality curve)
- Mean Time between failures
 - Manufacturer's data, Industrial database, Laboratory experience
- Mean time to repair
 - Engineering estimate, Laboratory experience
- Spares and Repair
 - Type (hot, cold)
 - Replacement (on line, off line)
 - Repair (on line, off line, on line for first and off line for second)

RAM Spreadsheet Example



S	S	A	Equipment/Failure Mode	Failure Rate (1/h x 10 ⁻⁶)	Failure Rate Source	MTBF (h)	Percent of Anticip ated Failures	Effective MTBF for Unanticipated Failures (h)	Effective Failure Rate (1/h x 10 ⁻⁶)
y	u	s							
s	b	s							
t	e	e							
e	m	m							
m		y							
			RCCS						
			Pump	40.00	Bernardin/Dortwegt	25000	75	100000.0	10.00
			Variable Frequency Drive	20.00	Bernardin/Dortwegt	50000	0	50000.0	20.00
			Control Valve	0.30	Bernardin/Brown (7/9/01)	250000	0	250000.0	4.00
			Piping Leak	3.00	K. Kern (5/18/99)	333333	0	333333.3	3.00
			Constant Flow Valve	1.00	Bernardin/Dortwegt	1000000	0	1000000.0	1.00
			Temperature/Pressure Sensor	30.00	Bernardin/Brown (7/9/01)	33333	0	33333.3	30.00
			Hose Leak	1.80	K. Kern (5/18/99)	555556	0	555555.6	1.80
			RCCS					25125.5	39.80
			Transmitter (Titan SNS1) 402.5 and 805 MHz	124.00	Maxwell	8065	0	8064.5	124.00
			Interface/control	12.95	Titan FDR	77220	0	77220.1	12.95
			AC distrubution Chassis	12.87	Titan FDR	77700	0	77700.1	12.87
			HV Enclosure	8.71	Titan FDR	114811	0	114810.6	8.71
			Magnet, Filament,Amp, Ion pump Supply	39.73	Titan FDR	25170	0	25169.9	39.73
			PPS Chassis	28.50	Titan FDR	35088	0	35087.7	28.50
			Water cooling	18.95	Titan FDR	52770	0	52770.4	18.95
			Titan SNS1 Transmitter Total	121.73				8214.7	121.73

RAM Spreadsheet Example continued



No. of Spares Included	Type of Redundancy (1=hot 2=cold)	Repair (0=off-line, 1=on-line, 2=supermod)	Effective Total Failure Rate (1/h x 10 ⁻⁶)	Estimated Average Annual Frequency of Repairs (=Spares)	Repair Personnel Required	Mean Time To Repair MTTR (h)	Other Delays MTTR _d (h)	Switch-over Time MTTS (h)	Mean Down Time MDT (h)	Estimated Average Total Annual Repair Time (h)	Steady State Availability
1	0	0	10.00	0.08	1	0.5			0.5	0.16	0.999995
1	0	0	20.00	0.16	1	0.5			0.5	0.08	0.999990
1	0	0	4.00	0.03	1	0.5			0.5	0.02	0.999998
1	0	0	3.00	0.02	1	0.5			0.5	0.01	0.999999
1	0	0	1.00	0.01	1	0.5			0.5	0.00	1.000000
1	1	1	30.00	0.23	1	0.5			0.5	0.12	1.000000
1	0	0	1.80	0.01	1	0.5			0.5	0.01	0.999999
	0	0	69.80	0.54					0.5	0.39	0.999980
1	0	0	124.00	0.96	2	2.0	0	0	4.0	7.69	0.999504
1	0	0	12.95	0.10	2	4.0	0		4.0	0.80	0.999948
1	0	0	12.87	0.10	2	4.0	0		4.0	0.80	0.999949
1	0	0	8.71	0.07	2	4.0	0		4.0	0.54	0.999965
1	0	0	39.73	0.31	2	4.0	0		4.0	2.46	0.999841
1	0	0	28.50	0.22	2	4.0	0		4.0	1.77	0.999886
1	0	0	18.95	0.15	2	4.0	0		4.0	1.18	0.999924
	0	0	121.71	0.94					4.0	7.55	0.999513

Accelerator Systems Initial RAM using an Industrial Database



System	Subsystem	MTBF(h)	Failure Rate (1/h x 10**6)	Mean Downtime	Est. Annual Repair Time	Steady State Availability
LINAC						
	DTL	629.0	1598.9	11.2	448.73	98.25%
	CCL	575.3	1738.2	10.6	514.03	98.27%
	Med. Beta SCL	469.5	2130.1	5.4	298.3	97.35%
	Hi. Beta SCL	341.3	2930.2	5.4	325.4	96.29%
	Crypolant	685.0	684.9	2.8	63.4	99.59%
	HEBT RF	3007.3	332.5	7.2	98.75	99.76%
Linac Total		95.6	10462.5	6.8	1748.8	89.92%
Linac RF		104.0	9612.3	5.4	988.4	95.04%

Note: This does not include the Front End

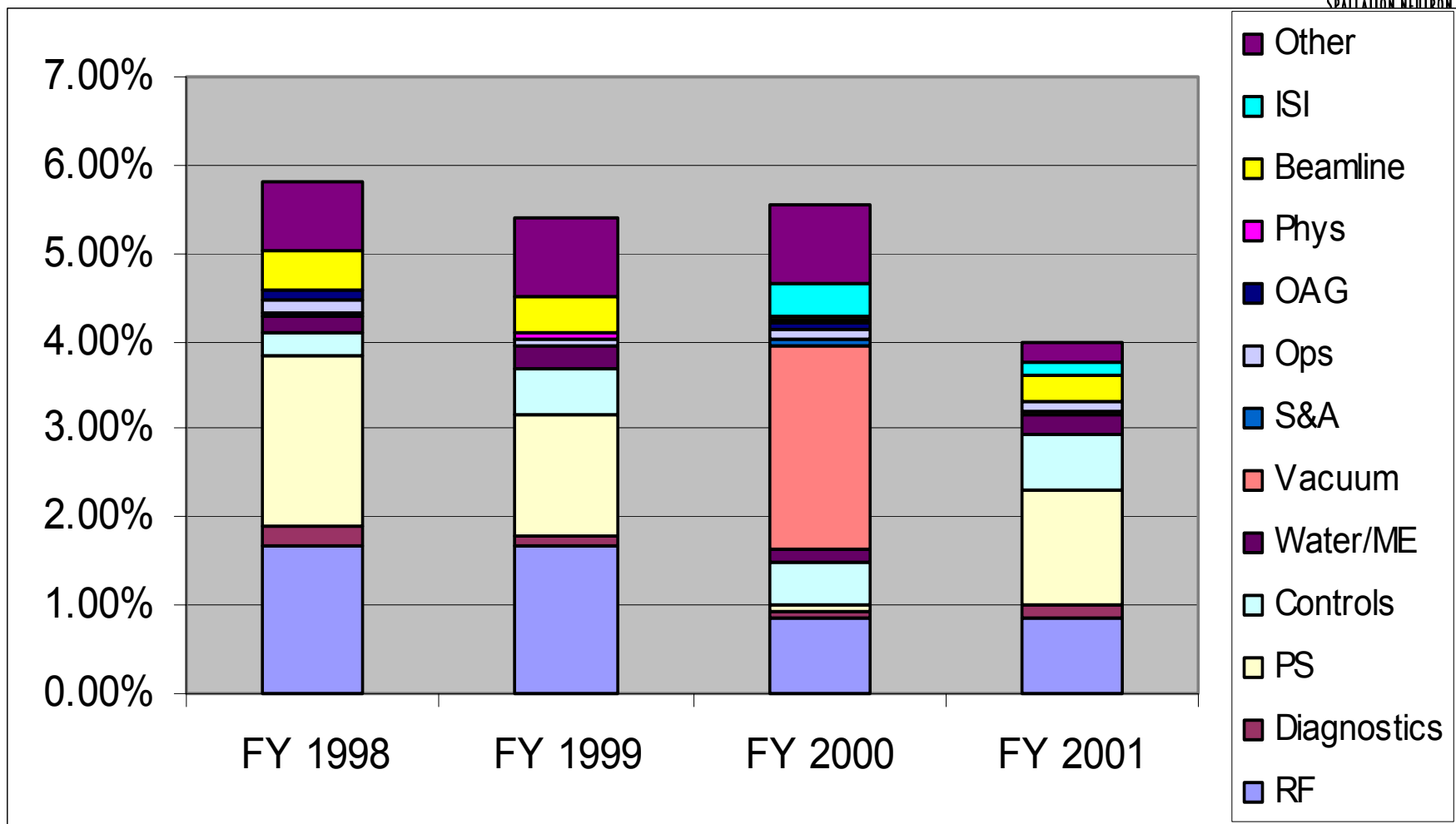
Accelerator Systems Initial RAM using an Industrial Database



System	Subsystem	MTBF(h)	Failure Rate (1/h x 10**6)	Mean Downtime	Est. Annual Repair Time	Steady State Availability
Magnets	Magnets	2317.2	431.6	10.1	67.43	99.56%
	Power Supplies	252.2	3965	2.0	122.3	99.12%
	PS Controllers	133.0	7520	2.0	183.7	98.82%
HEBT-Ring-RTBT Vacuum Ring Systems		702.4	1423.7	12.0	581.4	98.32%
	Ring RF System	1544.0	2550	8.0	1265	94.10%
	Extraction Kicke	12500.0	155	2.0	347	97.78%
	Injection Foil Dri	2000.0	500	8.0	327	99.40%
	Collimators	83000.0	1.2	100.0	13	99.92%
Controls						
	EPICS	26800.0	207.8	2.0	415.5	94.78%
	Timing System	350.0	2.27	2.0	5.34	99.93%
	PPS	8310.0	64.42	2.0	128.8	98.35%
	MPS	2000.0	15.5	2.0		99.60%
	Total	37460.0	290.4	2.0	580.8	92.78%
Accelerator Systems Total						73.11%

2000-0xxxx/vlb

APS Unavailability



Comparison of Industrial and Accelerator Databases



Industrial Database	
Magnetics Total	97.53%
Controls Total	92.78%
Accelerator Database using JLAB and APS	
Magnetics Total	99.78%
Controls Total	99.22%

Revised RAMI Summary



System	Subsystem	Initial Analysis Availability	Revised Analysis Availability	Justification
LINAC				
	DTL	98.25%	98.25%	
	CCL	98.27%	98.27%	
	Med. Beta SCL	97.35%	99.81%	one cavity off line
	Hi. Beta SCL	96.29%	99.53%	one cavity off line
	Crypolant	99.59%	99.73%	
	HEBT RF	99.76%	99.76%	
Linac Total		89.92%	95.43%	
Magnetics				
	Magnets	99.56%		
	Power Supplies	99.12%		
	PS Controllers	98.82%		
	Total	97.53%	99.78%	APS-JLAB Scaling
Ring Systems				
	Ring RF System	94.10%	99.80%	one cavity off line
	Extraction Kickers	97.78%	99.70%	one module off line
	Injection Foil Drive	99.40%	99.40%	
	Collimators	99.92%	99.92%	
	Total	91.38%	98.82%	
HEBT-Ring-RTBT Vacuum		98.32%	98.32%	
Controls				
	EPICS	94.78%		
	Timing System	99.93%		
	PPS	98.35%		
	MPS	99.60%		
Controls Total		92.78%	99.22%	APS-JLAB Scaling
Accelerator Systems Total		73.11%	91.79%	

Suggested Paths to High Availability



- Add redundancy and fault tolerance to the systems, e.g.
 - Front End - Modify Front End for two ion sources
 - RF Systems - Add another hot standby transmitter
 - Superconducting LINAC - Add more cryomodules
- Purchase Power supplies rated for higher power
- Operate beam at a lower average power

Paths to High Availability: Comments from Engineers



- Purchase over-rated power supplies
 - MTBF increases as $(I_{\text{operating}}/I_{\text{rating}})$
 - Using the APS-Jlab scaling, power supplies are already above 99.8%,
- Cooling – get a factor of 2 in MTBF for 10°C in cooling for electronics
 - Air cooling in power supply rooms
 - Water cooling – parallel cooling not series
- Use 1/2 or 2/3 model (NLC talk P. Bellomo)
- Use MIL-HDBK- 217 parts. (MTBF goes to ~140,000h)

Paths to High Availability: Comments from Engineers



- Operate beam at a lower average power
 - 60 Hz at half peak current
 - No effect on DC systems
 - AC systems run at same PRF, some more lightly loaded - slight increase in MTBF – but, run twice as long for the same neutron flux
 - 30 Hz at full peak current
 - Users want 60 Hz operation
 - No effect on DC Systems
 - AC systems run at half the PRF – but, run twice as long for the same neutron flux
- Operate at reduced power while repairs are underway (Klystron, Kickers, Ring RF)

Approaches to High Availability: Operating Schedule



- Availability is not steady state reliability.
- Schedule one shift of PM and one, plus recovery shifts per week. These do not count against availability
- Tactical approach: “ tune around it until the PM day” not “run until it breaks”.

Maintenance



- Initially use reliability calculation to predict MTBF of systems and components.
- Schedule proactive PM to replace components at an agreed percent of the anticipated lifetime.
 - Increases MTBF, does not act as “hot spares”
- Use “lessons learned” from actual failure rate to validate the real MTBF and MTTR

Use Operational Experience



- Track reliability/availability/maintenance with off-the-shelf MIS software
- ERAMS
 - integrated into SNS Oracle database
 - Cradle-to-grave equipment tracking using barcode
 - Direct access to: Installation data, maintenance history, fault history, vendor travelers, partner laboratory travelers, RATS testing results
 - Fault reporting
 - Work planning
 - Spares inventory
- Identify the systems that contribute the most to downtime

Reliability Improvement Program



- Identify the largest contributor to downtime
- Upgrades to the hardware specifications
 - Purchase overrated power supplies
- Upgrades are possible to hardware as supplied
 - Suggest hardware modifications based on operational experience
- Upgrades are possible to hardware as it is operated
 - Cooling
 - PM

Conclusion



- Presented reliability goals, a calculation with an industrial database and a comparison to recent accelerator experience.
- Described how a proactive PM program utilizing a MIS system for tracking the sources of beam unavailability will be used to increase availability.
- Showed a reliability improvement program focusing on system fault tolerance, redundancy and operating conditions.